TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7PG04AFE

Dual Inverter

Features

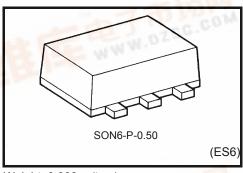
 High-level output current: I_{OH}/I_{OL} = ±8 mA (min) at V_{CC} = 3 V

• High-speed operation: $t_{pd} = 2.8 \text{ ns (typ.)}$

at $V_{CC} = 3.3 \text{ V}, 15 \text{pF}$

Operating voltage range: V_{CC} = 0.9~3.6 V

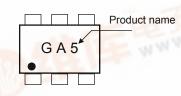
5.5-V tolerant inputs

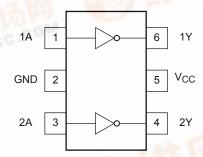


Weight: 0.003 g (typ.)

Marking

Pin Assignment (top view)





Absolute Maximum Ratings (Ta = 25°C)

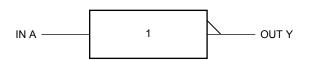
Characteristics	Symbol	Value	Unit
Power supply voltage	V _{CC}	-0.5~4.6	V
DC input voltage	V _{IN}	-0.5~7.0	V
DC output voltage	Vout	-0.5~V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	lok	±20 (Note 1)	mA
DC output current	lout	±25	mA
DC V _{CC} /GND current	Icc	±100	mA
Power dissipation	PD	150	mW
Storage temperature	T _{stg}	-65~150	°C

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1 Vout < GND, Vout > Vcc

IEC Logic Symbol



Truth Table

А	Y
L	Н
Н	L

Operating Range

Characteristics	Symbol	Value	Unit		
Power supply voltage	V _{CC}	0.9~3.6	V		
Input voltage	V _{IN}	0~5.5	V		
Output voltage	V _{OUT}	0~V _{CC} (Note 2)	V		
Output Current		±8.0 (Note 3)			
	I _{OH} /I _{OL}	±4.0 (Note 4)			
		±3.0 (Note 5)	mA		
		±1.7 (Note 6)	IIIA		
		±0.3 (Note 7)			
		±0.02 (Note 8)			
Operating temperature	T _{opr}	-40~85	°C		
Input rise and fall time	dt/dV	0~10 (Note 9)	ns/V		

Note 2: $V_{CC} = 3.0 \sim 3.6 \text{ V}$

Note 3: $V_{CC} = 2.3 \sim 2.7 \text{ V}$

Note 4: $V_{CC} = 1.65 \sim 1.95 \text{ V}$

Note 5: $V_{CC} = 1.4 \sim 1.6 \text{ V}$

Note 6: $V_{CC} = 1.1 \sim 1.3 \text{ V}$

Note 7: $V_{CC} = 0.9 V$

Note 8: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$



Electrical Characteristics

DC Electrical Characteristics

Characteristics Symbol Test Condition			Га = 25°(= 25°C		Ta = -40~85°C				
		Condition	V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit	
High-level V _{IH} input voltage				V_{CC}		_	V _C C			
				V _{CC} × 0.7	1	_	V _{CC} × 0.7			
	_		1.4~1.6	V _{CC} × 0.65			V _{CC} × 0.65		V	
			1.65~1.95	V _{CC} × 0.65			V _{CC} × 0.65			
			2.3~2.7	1.7		_	1.7			
				3.0~3.6	2.0		_	2.0		
					_	_	GND	_	GND	
				1.1~1.3			V _{CC} × 0.3	_	V _{CC} × 0.3	
Low-level	V _{IL}		_				V _{CC} × 0.35	_	V _{CC} × 0.35	V
input voltage				-	_	V _{CC} × 0.35	_	V _{CC} × 0.35		
					_	_	0.7		0.7	
				3.0~3.6			0.8		0.8	
			$I_{OH} = -0.02 \text{ mA}$	0.9	0.75		_	0.75		
			$I_{OH} = -0.3 \text{ mA}$	1.1~1.3	V _{CC} × 0.75	_	_	V _{CC} × 0.75	_	
High-level V _{OH}	$V_{IN} = V_{IL}$	I _{OH} = -1.7 mA	1.4~1.6	V _{CC} × 0.75	_	_	V _{CC} × 0.75		V	
		I _{OH} = -3.0 mA	1.65~ 1.95	V _{CC} -0.45	_	_	V _{CC} -0.45	_		
			$I_{OH} = -4.0 \text{ mA}$	2.3~2.7	2.0	_	_	2.0	_	
		$I_{OH} = -8.0 \text{ mA}$	3.0~3.6	2.48		_	2.48	_		
Low-level V _{OL} V _{IN}		$I_{OL} = 0.02 \text{ mA}$	0.9	_	_	0.1	_	0.1	V	
		I _{OL} = 0.3 mA	1.1~1.3		_	V _{CC} × 0.25	_	V _{CC} × 0.25		
	V _{IN} = V _{IH}	I _{OL} = 1.7 mA	1.4~1.6		_	V _{CC} × 0.25	_	V _{CC} × 0.25		
	VIN VIA	I _{OL} = 3.0 mA	1.65~ 1.95	_	_	0.45	_	0.45		
		I _{OL} = 4.0 mA	2.3~2.7	_	_	0.4		0.4		
		I _{OL} = 8.0 mA	3.0~3.6	_	_	0.4		0.4		
Input leakage current	I _{IN}	V _{IN} = 0~5.5V		0~3.6			±0.1	_	±1.0	μА
Quiescent supply current	Icc	V _{IN} = V _{CC} or GND		3.6	_	_	1.0	_	10.0	μА

3

AC Electrical Characteristics (input $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C		Unit	
			V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic
		$\begin{aligned} C_L &= 10 \text{ pF}, \\ R_L &= 1 \text{ M}\Omega \end{aligned}$	0.9	_	27.2	_	_	_	-
			1.1~1.3	_	12.2	23.2	1.0	42.6	
			1.4~1.6	_	6.5	10.2	1.0	12.0	
			1.65~ 1.95	_	4.7	7.0	1.0	7.6	
			2.3~2.7	_	3.1	4.4	1.0	4.9	
			3.0~3.6		2.4	3.5	1.0	4.1	
		C_L = 15 pF, R_L = 1 M Ω	0.9	_	29.8	_	_	_	
	^t pLH ^t pHL		1.1~1.3	_	13.5	26.0	1.0	44.5	ns
Propagation delay time			1.4~1.6	_	7.2	11.4	1.0	13.6	
Propagation delay time			1.65~ 1.95	_	5.2	7.5	1.0	7.7	
			2.3~2.7		3.4	4.8	1.0	5.5	
			3.0~3.6		2.8	3.8	1.0	4.4	
		$C_L = 30 \text{ pF},$ $R_L = 1 \text{ M}\Omega$	0.9		40.7		_		
			1.1~1.3	_	17.8	33.9	1.0	64.1	
			1.4~1.6	_	9.1	14.3	1.0	17.4	
			1.65~ 1.95	_	6.6	9.8	1.0	10.2	
			2.3~2.7		4.1	6.2	1.0	6.6	
			3.0~3.6		3.3	4.8	1.0	5.2	
Input capacitance	C _{IN}		3.6		3	_	_	_	pF
Power dissipation capacitance	C _{PD}	(Note 9)	0.9 ~ 3.6	_	6	_		_	pF

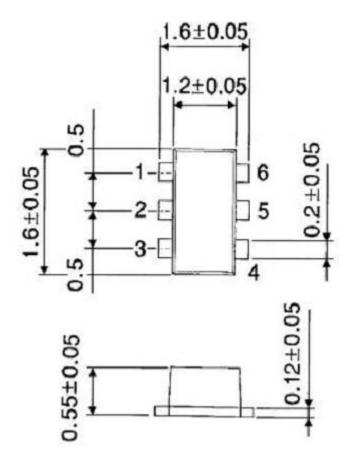
Note 9: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2$

Package Dimensions

SON6-P-0.50 Unit: mm



Weight: 0.003 g (typ.)

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20070701-EN GENERAL

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